4 A Synchronous Buck Power MOSFET Driver

The NCP5351 is a dual MOSFET gate driver optimized to drive the gates of both high-side and low-side Power MOSFETs in a Synchronous Buck converter. The NCP5351 is an excellent companion to multiphase controllers that do not have integrated gate drivers, such as ON Semiconductor's CS5323, CS5305 or CS5307. This architecture provides a power supply designer the flexibility to locate the gate drivers close to the MOSFETs.

The 4.0 A drive capability makes the NCP5351 ideal for minimizing switching losses in MOSFETs with large input capacitance. Optimized internal, adaptive nonoverlap circuitry further reduces switching losses by preventing simultaneous conduction of both MOSFETs.

The floating top driver design can accommodate MOSFET drain voltages as high as 25 V. Both gate outputs can be driven low, and supply current reduced to less than 25 μ A, by applying a low logic level to the Enable (EN) pin. An undervoltage lockout function ensures that both driver outputs are low when the supply voltage is low, and a thermal shutdown function provides the IC with overtemperature protection.

The NCP5351 is pin-to-pin compatible with the SC1205 and is available in a standard SO-8 package and thermally enhanced DFN10.

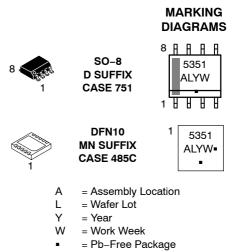
Features

- 4.0 A Peak Drive Current
- Rise and Fall Times < 15 ns Typical into 6000 pF
- Propagation Delay from Inputs to Outputs < 20 ns
- Adaptive Nonoverlap Time Optimized for Large Power MOSFETs
- Floating Top Driver Accommodates Applications Up to 25 V
- Undervoltage Lockout to Prevent Switching when the Input Voltage is Low
- Thermal Shutdown Protection Against Overtemperature
- < 1.0 mA Quiescent Current Enabled
- 25 µA Quiescent Current Disabled
- Internal TG to DRN Pulldown Resistor Prevents HV Supply-Induced Turn On of High-Side MOSFET
- Pb–Free Package is Available

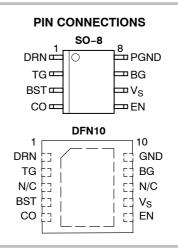


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(Note: Microdot may be in either location)



ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 12 of this data sheet.

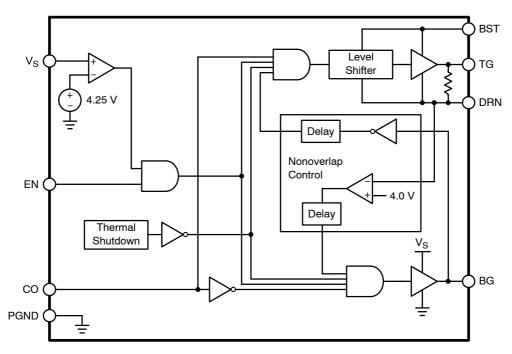


Figure 1. Block Diagram

Table 1. Input-Output Truth Table

EN	со	DRN	TG	BG
L	Х	Х	L	L
Н	L	< 3.0 V	L	Н
Н	Н	< 3.0 V	Н	L
Н	L	> 5.0 V	L	L
Н	Н	> 5.0 V	Н	L

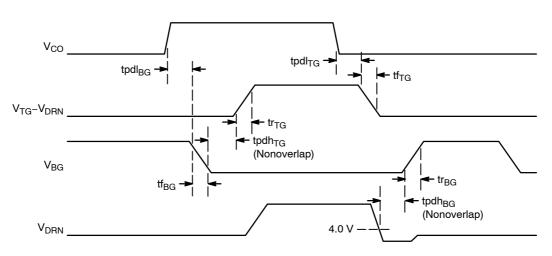


Figure 2. Timing Diagram

PACKAGE PIN DESCRIPTION

Pin N	umber		
SO-8	DFN-10	Pin Symbol	Description
1	1	DRN	The switching node common to the high and low-side FETs. The high-side (TG) driver and supply (BST) are referenced to this pin.
2	2	TG	Driver output to the high-side MOSFET gate.
3	4	BST	Bootstrap supply voltage input. In conjunction with a Schottky diode to V _S , a 0.1 μ F to 1.0 μ F ceramic capacitor connected between BST and DRN develops supply voltage for the high-side driver (TG).
4	5	CO	Logic level control input produces complementary output states – no inversion at TG; inversion at BG.
-	3, 8	N/C	Not Connected.
5	6	EN	Logic level enable input forces TG and BG low, and supply current to 10 μA when EN is low.
6	7	V _S	Power supply input. A 0.1 μF to 1.0 μF ceramic capacitor should be connected from this pin to PGND.
7	9	BG	Driver output to the low-side (synchronous rectifier) MOSFET gate.
8	-	PGND	Ground.
_	10	GND	Ground.

MAXIMUM RATINGS - SO-8

Rating	Value	Unit
Operating Junction Temperature, T _J	Internally Limited	°C
Package Thermal Resistance: SO-8 Junction-to-Case, R _{θJC} Junction-to-Ambient, R _{θJA}	45 165	°C/W °C/W
Storage Temperature Range, T _S	-65 to 150	°C
Lead Temperature Soldering: Reflow: (SMD styles only) (Note 1) Pb-Free		°C
MSL Rating	1	-

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

NOTE: This device is ESD sensitive. Use standard ESD precautions when handling.

1. 60 seconds maximum above 183°C.

MAXIMUM RATINGS - DFN-10

Rating	Symbol	Value	Unit	
Thermal Resistance, Junction-to-Air		R _{JA}	68.5	°C/W
Operating Ambient Temperature Range		T _A	–30 to 85	°C
ESD Withstand Voltage	Human Body Model (Note 2) Machine Model (Note 2)	V _{ESD}	> 2500 > 150	V
Moisture Sensitivity		MSL	Level 1	
Storage Temperature Range		T _{stg}	–55 to 150	°C
Junction Operating Temperature		TJ	-30 to 125	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

2. This device series contains ESD protection and exceeds the following tests:

Human Body Model, 100 pF discharge through a 1.5 kΩ following specification JESD22/A114. Machine Model, 200 pF discharged through all pins following specification JESD22/A115. Latchup as per JESD78 Class II: > 100 mA.

MAXIMUM RATINGS

Pin Symbol	Pin Name	V _{MAX}	V _{MIN}	ISOURCE	I _{SINK}
V _S	Main Supply Voltage Input	6.3 V	–0.3 V	NA	4.0 A Peak (< 100 μs) 250 mA DC
BST	Bootstrap Supply Voltage Input	25 V wrt/PGND 6.3 V wrt/DRN	–0.3 V wrt/DRN	NA	4.0 A Peak (< 100 μs) 250 mA DC
DRN	Switching Node (Bootstrap Supply Return)	25 V	–1.0 V DC –5.0 V for 100 ns –6.0 V for 20 ns	4.0 A Peak (< 100 μs) 250 mA DC	NA
TG	High–Side Driver Output (Top Gate)	25 V wrt/PGND 6.3 V wrt/DRN	–0.3 V wrt/DRN	4.0 A Peak (< 100 μs) 250 mA DC	4.0 A Peak (< 100 μs) 250 mA DC
BG	Low–Side Driver Output (Bottom Gate)	6.3 V	–0.3 V	4.0 A Peak (< 100 μs) 250 mA DC	4.0 A Peak (< 100 μs) 250 mA DC
CO	TG & BG Control Input	6.3 V	–0.3 V	1.0 mA	1.0 mA
EN	Enable Input	6.3 V	–0.3 V	1.0 mA	1.0 mA
PGND	Ground	0 V	0 V	4.0 A Peak (< 100 μs) 250 mA DC	NA

NOTE: All voltages are with respect to PGND except where noted.

Parameter	Test Conditions	Min	Тур	Max	Unit
DC OPERATING SPECIFICATIONS POWER SUPPLY	3	-	-	_	
V _S Quiescent Current, Operating	$V_{CO} = 0 \text{ V}, 4.5 \text{ V}; \text{ No output switching}$	-	1.0	_	mA
V _{BST} Quiescent Current, Operat- ing	V _{CO} = 0 V, 4.5 V; No output switching	-	50	-	μA
Quiescent Current, Non–Operat- ing	$V_{EN} = 0 \text{ V}; \text{ V}_{CO} = 0 \text{ V}, 4.5 \text{ V}$	-	-	25	μA
Undervoltage Lockout					
Start Threshold	CO = 0 V	4.05	4.25	4.48	V
Hysteresis	CO = 0 V	_	275	-	mV
CO INPUT CHARACTERISTICS					
High Threshold	-	2.0	-	-	V
Low Threshold	-	-	-	0.8	V
Input Bias Current	$0 < V_{CO} < V_{S}$	-	0	1.0	μA
EN INPUT CHARACTERISTICS					
High Threshold	Both outputs respond to CO	2.0	-	-	V
Low Threshold	Both outputs are low, independent of CO	-	-	0.8	V
Input Bias Current	0 < V _{EN} < V _S	-	0	10	μA
THERMAL SHUTDOWN					
Overtemperature Trip Point	-	-	170	-	°C
Hysteresis	-	-	30	-	°C
HIGH-SIDE DRIVER					
Peak Output Current	-	-	4.0	-	А
Output Resistance (Sourcing)	Duty Cycle < 2.0%, Pulse Width < 100 μ s, T_J = 125°C, V_{BST} – V_{DRN} = 4.5 V, V_{TG} = 4.0 V + V_{DRN}	-	0.5	-	Ω
Output Resistance (Sinking)	Duty Cycle < 2.0%, Pulse Width < 100 μ s, T_J = 125°C, V_{BST} - V_{DRN} = 4.5 V, V_{TG} = 0.5 V + V_{DRN}	-	0.42	_	Ω
LOW-SIDE DRIVER					
Peak Output Current –		_	4.0	-	А
Output Resistance (Sourcing)	Duty Cycle < 2.0%, Pulse Width < 100 $\mu s,T_J$ = 125°C, V_S = 4.5 V, V_{BG} = 4.0 V	-	0.6	-	Ω
		+	1		

Duty Cycle < 2.0%, Pulse Width < 100 $\mu s,$ T_J = 125°C, V_S = 4.5 V, V_{BG} = 0.5 V

0.42

-

Ω

-

Output Resistance (Sinking)

ELECTRICAL CHARACTERISTICS (continued) (0°C < T_J < 125°C; V_S = 5.0 V; 4.0 V < V_{BST} < 25 V; V_{EN} = V_S, C_{LOAD} = 5.7 nF; unless otherwise noted.)

Parameter	Test Conditions	Min	Тур	Max	Unit
AC OPERATING SPECIFICATIONS HIGH-SIDE DRIVER	3				
Rise Time	$V_{BST} - V_{DRN} = 5.0 \text{ V}, \text{ T}_{J} = 125^{\circ}\text{C}$	-	8.0	16	ns
Fall Time	$V_{BST} - V_{DRN} = 5.0 \text{ V}, \text{ T}_{J} = 125^{\circ}\text{C}$	-	14	21	ns
Propagation Delay Time, TG Going High (Nonoverlap Time)	$V_{BST} - V_{DRN} = 5.0 \text{ V}, \text{ T}_{J} = 125^{\circ}\text{C}$	30	45	60	ns
Propagation Delay Time, TG Going Low	V_{BST} – V_{DRN} = 5.0 V, T_J = 125°C	-	18	37	ns
LOW-SIDE DRIVER					
Rise Time	T _J = 125°C	-	10	15	ns
Fall Time	$T_J = 125^{\circ}C$	-	12	20	ns
Propagation Delay Time, BG Going High (Non–Overlap Time)	$T_{\rm J} = 125^{\circ}{\rm C}$	25	55	80	ns
Propagation Delay Time, BG Going Low	$T_J = 125^{\circ}C$	_	10	18	ns

UNDERVOLTAGE LOCKOUT

V _S Rising	EN = V _S , CO = 0 V, dV _S /dt > 1.0 V/µs, from 4.0 V to 4.5 V, time to BG > 1.0 V, T _J = 125°C	_	30	_	μs
V _S Falling	EN = V_S, CO = 0 V, dV_S/dt < –1.0 V/µs, from 4.5 V to 4.0 V, time to BG < 1.0 V, T_J = 125°C	-	500	_	μs

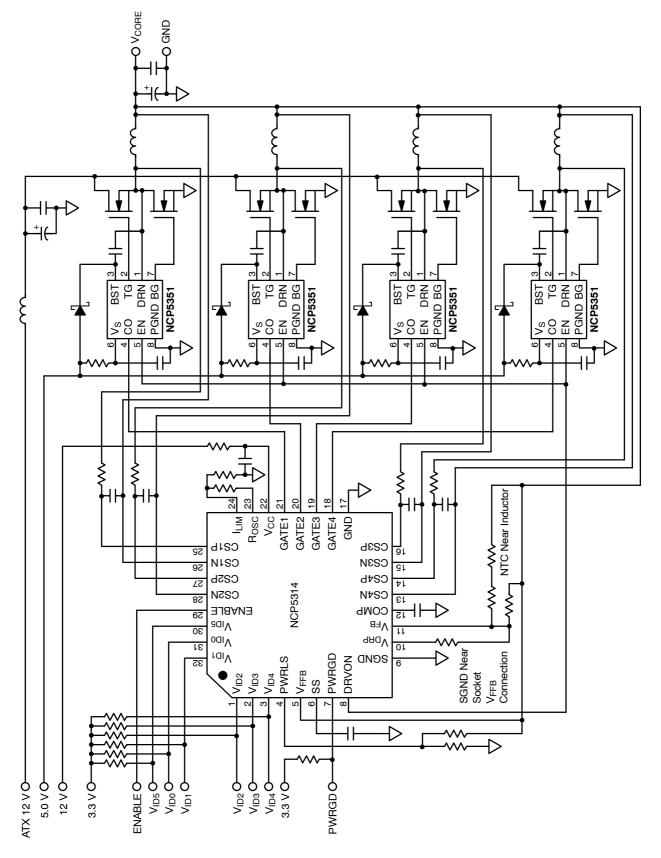


Figure 3. Application Diagram

APPLICATIONS INFORMATION

Theory Of Operation

Enable Pin

The Enable Pin (EN) is controlled by a logic level input. With a logic level high on the EN pin, the output states of the drivers are controlled by applying a logic level voltage to the CO pin. With a logic level low both gates are forced low. By bringing both gates low when disabling, the output voltage is prevented from ringing below ground, which could potentially cause damage to the microprocessor or the device being powered.

Undervoltage Lockout

The TG and BG are held low until V_S reaches 4.25 V during startup. The CO pin takes control of the gates' states when the V_S threshold is exceeded. If V_S decreases 300 mV below threshold, the output gate will be forced low and remain low until V_S rises above startup threshold.

Adaptive Nonoverlap

The Adaptive Nonoverlap prevents a condition where the top and bottom MOSFETs conduct at the same time and short the input supply. When the top MOSFET is turning off, the drain (switch node) is sampled and the BG is disabled for a fixed delay time (tpdh_{BG}) after the drain drops below 4 V, thus eliminating the possibility of shoot-through. When the bottom MOSFET is turning off, TG is disabled for a fixed delay (tpdh_{TG}) after BG drops below 2.0 V. (See Figure 2 for complete timing information).

Layout Guidelines

When designing any switching regulator, the layout is very important for proper operation. The designer should follow some simple layout guidelines when incorporating gate drivers in their designs. Gate drives experience high di/dt during switching and the inductance of gate drive traces should be minimized. Gate drive traces should be kept as short and wide as practical and should have a return path directly below the gate trace. The use of a ground plane is a desirable way to return ground signals. Also, component location will make a difference. The boost and the V_S capacitor are the most critical and should be placed as close as possible to the driver IC pins, as shown in Figure 4(a), C21 and C17.

5 V

12 V

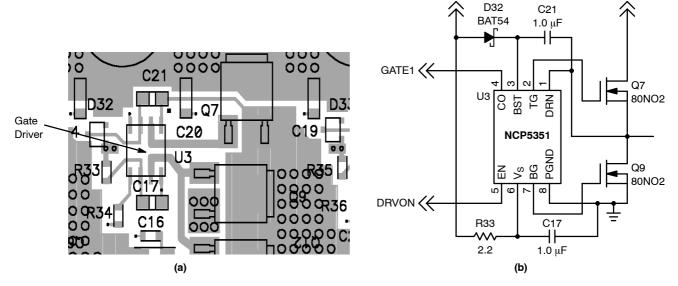
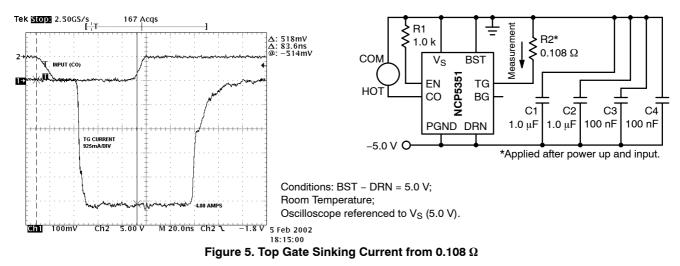
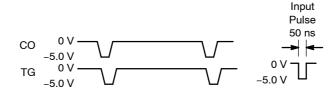


Figure 4. Proper Layout (a), Component Selection (b)

TYPICAL PERFORMANCE CHARACTERISTICS







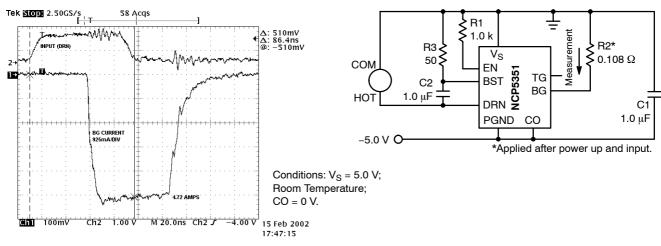


Figure 7. Bottom Gate Sinking Current from 0.108 Ω

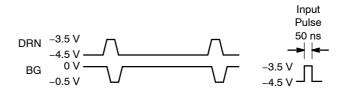
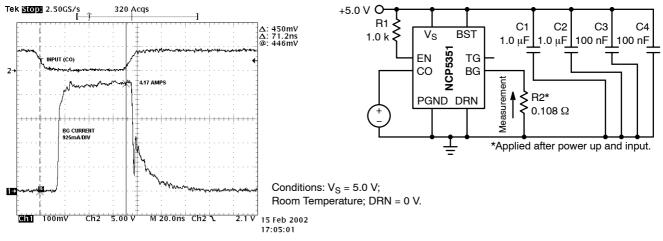
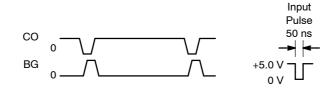


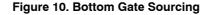
Figure 8. Bottom Gate Sinking

TYPICAL PERFORMANCE CHARACTERISTICS









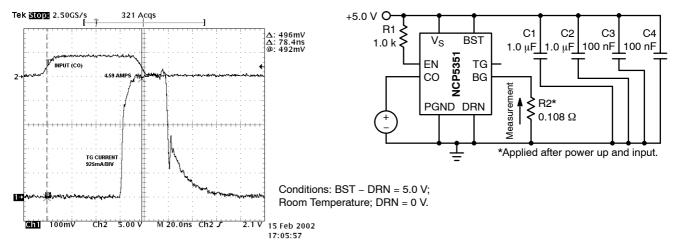


Figure 11. Top Gate Sourcing Current into 0.108 Ω

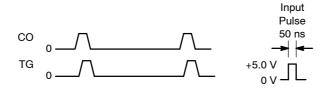
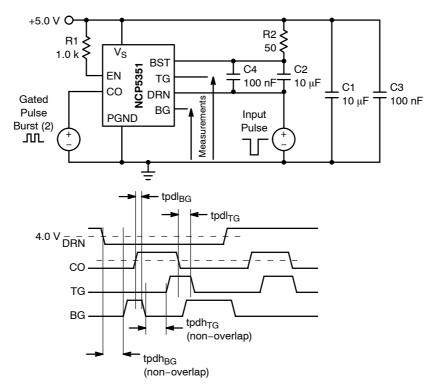
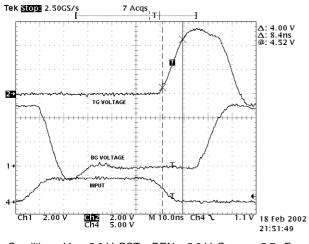


Figure 12. Top Gate Sourcing

TYPICAL PERFORMANCE CHARACTERISTICS

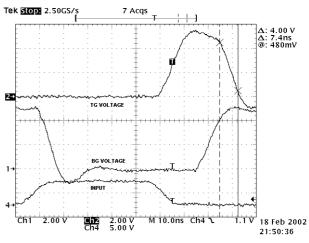






Conditions: $V_S = 5.0 \text{ V}$; BST – DRN = 5.0 V; $C_{LOAD} = 5.7 \text{ nF}$; Room Temperature.

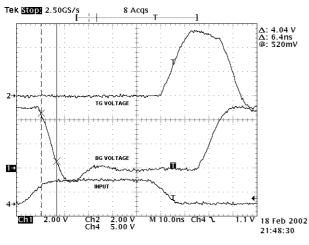




Conditions: V_S = 5.0 V; BST – DRN = 5.0 V; C_{LOAD} = 5.7 nF; Room Temperature.

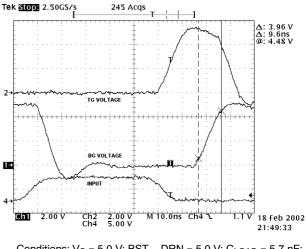






Conditions: V_S = 5.0 V; BST – DRN = 5.0 V; C_{LOAD} = 5.7 nF; Room Temperature.

Figure 16. Bottom Gate Fall Time



Conditions: V_S = 5.0 V; BST – DRN = 5.0 V; C_{LOAD} = 5.7 nF; Room Temperature.

Figure 17. Bottom Gate Rise Time

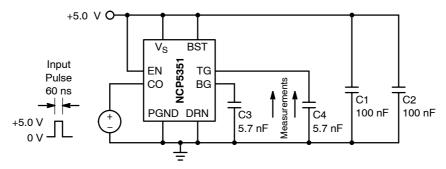


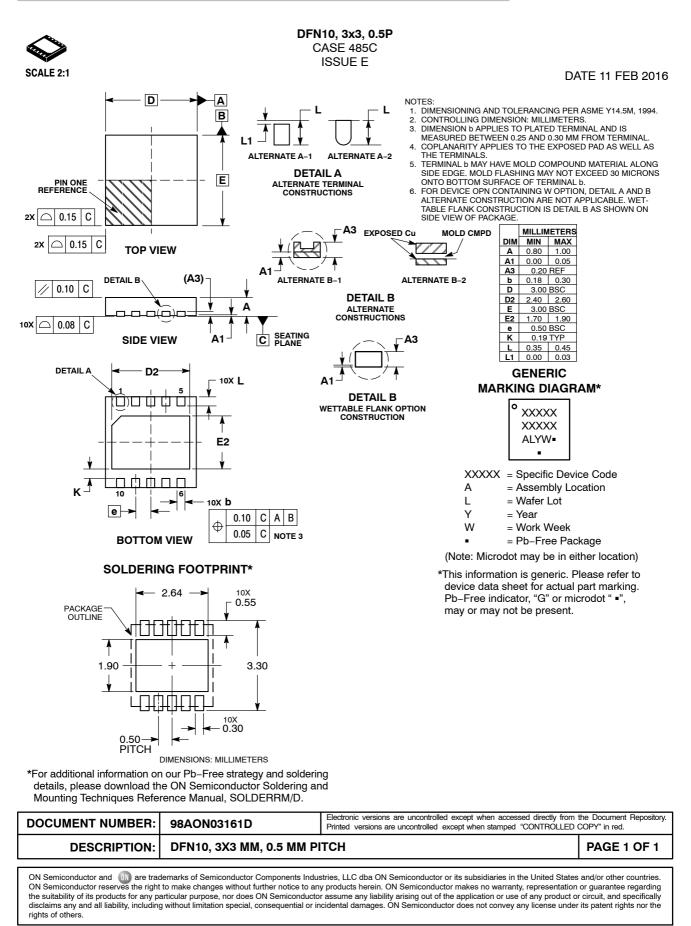
Figure 18. Bottom Gate and Top Gate Rise/Fall Time Test

ORDERING INFORMATION

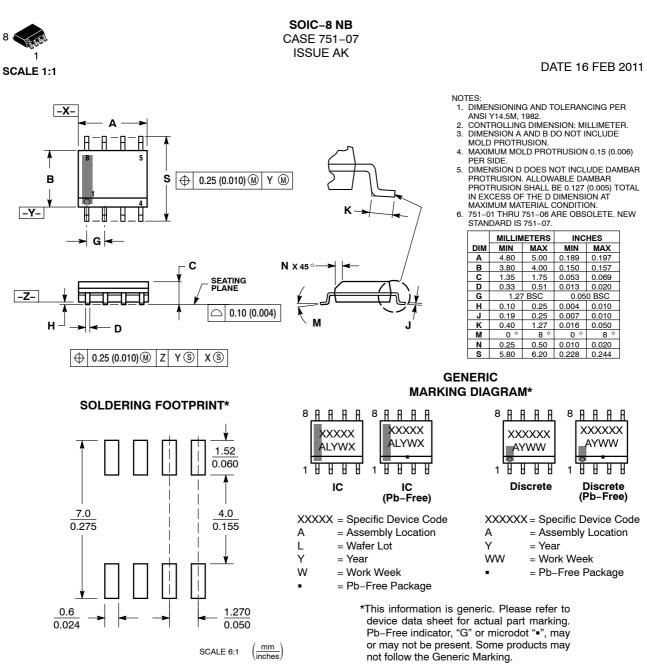
Device	Package	Shipping [†]
NCP5351D	SOIC-8	98 Units / Rail
NCP5351DG	SOIC–8 (Pb–Free)	98 Units / Rail
NCP5351DR2	SOIC-8	2500 / Tape & Reel
NCP5351DR2G	SOIC–8 (Pb–Free)	2500 / Tape & Reel
NCP5351MNR2	DFN10	2500 / Tape & Reel
NCP5351MNR2G	DFN10 (Pb–Free)	2500 / Tape & Reel

† For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.









*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

STYLES ON PAGE 2

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SOIC-8 NB CASE 751-07 **ISSUE AK**

STYLE 1: PIN 1. EMITTER COLLECTOR 2. З. COLLECTOR EMITTER 4 5 FMITTER BASE 6. 7. BASE 8. EMITTER STYLE 5: PIN 1. DRAIN 2. DRAIN З. DRAIN DRAIN 4. GATE 5. 6. GATE 7 SOURCE 8. SOURCE STYLE 9 PIN 1. EMITTER, COMMON 2. COLLECTOR, DIE #1 3 COLLECTOR, DIE #2 EMITTER, COMMON 4. 5 EMITTER, COMMON BASE, DIE #2 BASE, DIE #1 6. 7. EMITTER, COMMON 8. STYLE 13: PIN 1. N.C SOURCE 2. 3 SOURCE GATE 4. 5. DRAIN 6. DRAIN DRAIN 7. 8. DRAIN STYLE 17: PIN 1. VCC 2. V2OUT З. V10UT TXE 4. 5. RXE 6. VFF GND 7. 8. ACC STYLE 21: CATHODE 1 PIN 1. 2. CATHODE 2 3 CATHODE 3 CATHODE 4 4. 5. CATHODE 5 6. COMMON ANODE COMMON ANODE 7 8. CATHODE 6 STYLE 25: PIN 1. VIN 2 N/C 3. REXT

GND

IOUT 6.

BASE, DIE #1

EMITTER, #1

EMITTER, #2

COLLECTOR, #2

COLLECTOR, #2 COLLECTOR, #1

COLLECTOR #1

BASE. #2

4.

5. IOUT

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rights of others.

STYLE 29: PIN 1.

STYLE 2: PIN 1. COLLECTOR, DIE, #1 COLLECTOR, #1 2. COLLECTOR, #2 З. COLLECTOR, #2 4 5 BASE #2 EMITTER, #2 6. BASE, #1 8. EMITTER, #1 STYLE 6: PIN 1. SOURCE 2. DRAIN DRAIN SOURCE з 4. SOURCE 5. 6. GATE 7 GATE 8. SOURCE STYLE 10: PIN 1. GROUND 2. BIAS 1 3. OUTPUT GROUND 4. 5. GROUND 6. BIAS 2 INPUT 7. GROUND 8. STYLE 14 PIN 1. N-SOURCE N-GATE 2. 3 P-SOURCE P-GATE 4. P-DRAIN 5. 6. P-DRAIN 7. N-DRAIN 8. N-DRAIN STYLE 18 PIN 1. ANODE 2. ANODE 3 SOURCE GATE 4. DRAIN 5. 6 DRAIN CATHODE 7. 8. CATHODE STYLE 22 PIN 1. I/O LINE 1 COMMON CATHODE/VCC 2. 3 COMMON CATHODE/VCC I/O LINE 3 4. COMMON ANODE/GND 5. 6. I/O LINE 4 7 1/0 LINE 5 8. COMMON ANODE/GND STYLE 26: PIN 1. GND 2 dv/dt ENABLE З. ILIMIT 4. 5. SOURCE SOURCE 6. 7. SOURCE 8. VCC STYLE 30: DRAIN 1 PIN 1. DRAIN 1 2 GATE 2 З. 4 SOURCE 2 SOURCE 1/DRAIN 2 SOURCE 1/DRAIN 2 5. 6. 7. SOURCE 1/DRAIN 2

8 GATE 1

STYLE 3: PIN 1. DRAIN, DIE #1 DRAIN, #1 2. DRAIN, #2 З. DRAIN, #2 4 5 GATE #2 SOURCE, #2 6. GATE. #1 8. SOURCE, #1 STYLE 7: PIN 1. INPUT 2. EXTERNAL BYPASS THIRD STAGE SOURCE З. GROUND 4. DRAIN 5. 6. GATE 3 SECOND STAGE Vd 7 8. FIRST STAGE Vd STYLE 11 PIN 1. SOURCE 1 2. GATE 1 3 SOURCE 2 GATE 2 4. 5. DRAIN 2 6. DRAIN 2 DRAIN 1 7. 8. DRAIN 1 STYLE 15: PIN 1. ANODE 1 2. ANODE 1 3 ANODE 1 ANODE 1 4. CATHODE, COMMON 5. 6. CATHODE, COMMON CATHODE, COMMON 7. 8. CATHODE, COMMON STYLE 19 PIN 1. SOURCE 1 2. GATE 1 З. SOURCE 2 GATE 2 4. 5. DRAIN 2 6. MIRROR 2 DRAIN 1 7. 8. **MIRROR 1** STYLE 23 PIN 1. LINE 1 IN COMMON ANODE/GND 2. З. COMMON ANODE/GND LINE 2 IN 4. LINE 2 OUT 5. 6. COMMON ANODE/GND COMMON ANODE/GND 7 LINE 1 OUT 8. STYLE 27: PIN 1. ILIMIT 2 OVI O UVLO З. INPUT+ 4. 5. SOURCE SOURCE 6. 7. SOURCE 8 DRAIN

STYLE 4: PIN 1. ANODE ANODE 2. З. ANODE 4. ANODE 5 ANODE ANODE 6. ANODE 8. COMMON CATHODE PIN 1. COLLECTOR, DIE #1 2. BASE: #1 STYLE 8: З. BASE, #2 COLLECTOR. #2 4. COLLECTOR, #2 5. 6. EMITTER, #2 EMITTER #1 7 COLLECTOR, #1 8. STYLE 12: PIN 1. SOURCE 2. SOURCE SOURCE GATE 3. 4. 5. DRAIN 6. DRAIN DRAIN 7. 8. DRAIN STYLE 16: PIN 1. EMITTER, DIE #1 BASE, DIE #1 2. 3 EMITTER DIE #2 BASE, DIE #2 4. COLLECTOR, DIE #2 5. 6. COLLECTOR, DIE #2 7. COLLECTOR. DIE #1 8. COLLECTOR, DIE #1 2. GATE (N) SOURCE (P) 3. 4. GATE (P) DRAIN 5. 6. DRAIN DRAIN 7. 8. DRAIN 2. EMITTER

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STYLE 20: PIN 1. SOURCE (N) STYLE 24: PIN 1. BASE З. COLLECTOR/ANODE COLLECTOR/ANODE 4. 5. CATHODE 6. CATHODE

COLLECTOR/ANODE 7 COLLECTOR/ANODE 8.

0.	COLLECTOR, III
'LE 2	8:
N 1.	SW_TO_GND
2.	DASIC OFF
З.	DASIC SW DET
4.	GND
5.	V MON

6. VBULK

STY

PII

7. VBULK

8 VIN

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